

Vishay Siliconix

N-Channel 40 V (D-S) MOSFET



PRODUCT SUMMARY			
V _{DS} (V)	40		
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.00167		
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5 \text{ V}$	0.00224		
Q _g typ. (nC)	130		
I _D (A)	150 ^d		
Configuration	Single		

FEATURES

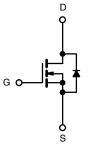
- TrenchFET® power MOSFET
- Maximum 175 °C junction temperature



- Excellent R_{DS}-Q_g and R_{DS}-Q_{oss} FOM reduce power loss from conduction and switching to enable high efficiency
- 100 % R_q and UIS tested
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

APPLICATIONS

- Power supply
 - Secondary synchronous rectification
- DC/DC converter
- Power tools
- Motor drive switch
- · Battery management



N-Channel MOSFET

ORDERING INFORMATION		
Package	TO-263	
Lead (Pb)-free and halogen-free	SUM40012EL-GE3	

ABSOLUTE MAXIMUM RATING	i S (T _C = 25 °C, unle	ess otherwise noted	d)		
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-source voltage		V _{DS}	40		
Gate-source voltage		V _{GS}	± 20		
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		150 ^d		
	T _C = 70 °C	l _D	150 ^d	1	
Pulsed drain current (t = 100 μs)		I _{DM}	300	A	
Avalanche current		I _{AS}	50		
Single avalanche energy ^a	L = 0.1 mH	E _{AS}	125	mJ	
Maximum power dissipation ^a	T _C = 25 °C	В	150 b	W	
iviaximum power dissipation 4	T _C = 125 °C	P _D	50 b	vv	
Operating junction and storage temperature range		T _J , T _{stq}	-55 to +175	°C	

THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	LIMIT	UNIT	
Junction-to-ambient (PCB mount) ^c	R _{thJA}	40	°C/W	
Junction-to-case (drain)	R _{thJC}	1		

Notes

- a. Duty cycle ≤ 1 %
- b. See SOA curve for voltage derating
- c. When mounted on 1" square PCB (FR4 material)
- d. Package limited

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SPECIFICATIONS (T _J = 25 ° PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static	OTMBOL	1201 CONDITIONS	IVIII V.		Wir O.	O.U.I
Drain-source breakdown voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	40	_	_	V
Gate threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	1	-	2.5	
Gate-body leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 250	nA
Zero gate voltage drain current	000	V _{DS} = 30 V, V _{GS} = 0 V	-	-	1	- μΑ
	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 125 °C	-	-	150	
G G		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 175 °C	-	-	5	mA
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	120	-	-	Α
-	_	V _{GS} = 10 V, I _D = 30 A	-	0.00139	0.00167	Ω
Drain-source on-state resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 20 A	-	0.00186	0.00224	
Forward transconductance a	9 _{fs}	V _{DS} = 15 V, I _D = 30 A	-	230	-	S
Dynamic ^b						
Input capacitance	C _{iss}		-	10 930	-	pF
Output capacitance	C _{oss}	$V_{GS} = 0 \text{ V}, V_{DS} = 20 \text{ V}, f = 1 \text{ MHz}$	-	2041	-	
Reverse transfer capacitance	C _{rss}		-	101	-	
Total gate charge ^c	Qg		-	130	195	
Gate-source charge ^c	Q _{gs}	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	33.6	-	nC
Gate-drain charge ^c	Q _{gd}	V _{DS} = 20 V, V _{GS} = 0 V	-	6.7	-	
Output charge	Q _{oss}		-	64	96	
Gate resistance	R _g	f = 1 MHz	0.36	1.8	3.6	Ω
Turn-on delay time c	t _{d(on)}		-	25	50	
Rise time ^c	t _r	$V_{DD} = 20 \text{ V}, R_L = 2 \Omega$	-	12	24	
Turn-off delay time ^c	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	65	130	ns -
Fall time ^c	t _f		-	18	36	
Drain-Source Body Diode Ratings	and Characte	ristics ^b (T _C = 25 °C)		•	•	
Pulsed current (t = 100 μs)	I _{SM}		-	-	300	Α
Forward voltage ^a	V _{SD}	I _F = 10 A, V _{GS} = 0 V	-	0.8	1.5	V
Reverse recovery time	t _{rr}		-	58	116	ns
Peak reverse recovery charge	I _{RM(REC)}	I _F = 10 A, di/dt = 100 A/μs	-	2.1	4.2	Α
Reverse recovery charge	Q _{rr}		-	72	144	nC
Reverse recovery fall time	t _a		-	32	-	ne
Reverse recovery rise time	t _b		-	26	-	ns

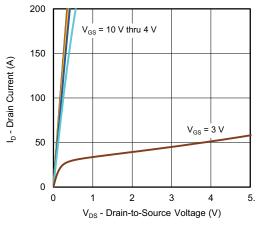
Notes

- a. Pulse test; pulse width $\leq 300~\mu\text{s},$ duty cycle $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing
- c. Independent of operating temperature

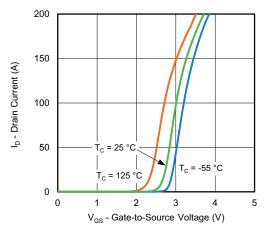
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



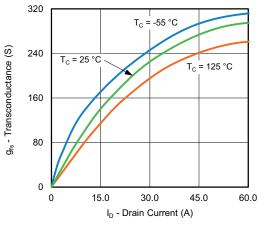
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)



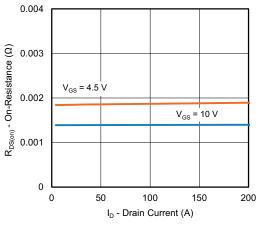
Output Characteristics



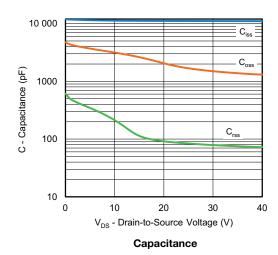
Transfer Characteristics

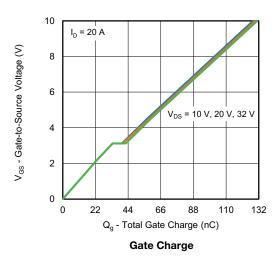


Transconductance



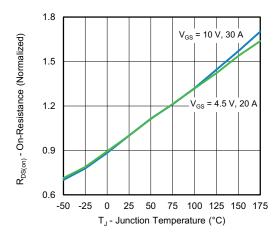
On-Resistance vs. Drain Current



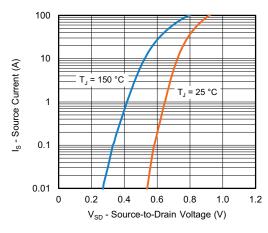




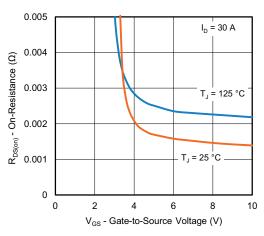
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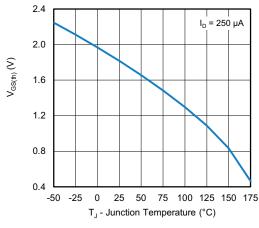
On-Resistance vs. Junction Temperature



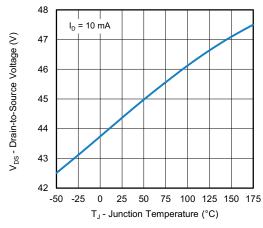
Source Drain Diode Forward Voltage



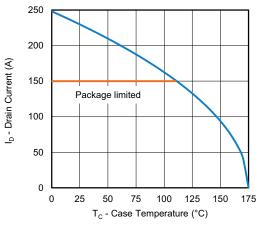
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



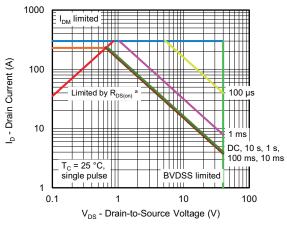
Drain Source Breakdown vs. Junction Temperature

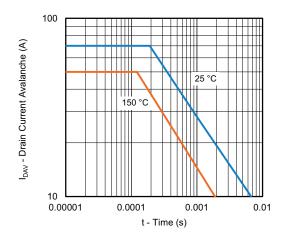


Current De-rating



THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)



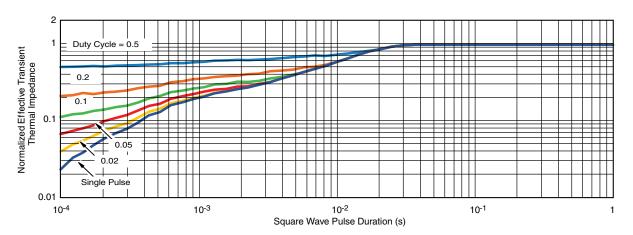


Safe Operating Area

Single Pulse Avalanche Current Capability vs. Time

Note

a. $V_{GS} > minimum V_{GS}$ at which $R_{DS(on)}$ is specified



Normalized Thermal Transient Impedance, Junction-to-Case

Note

- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction to Ambient (25 °C)
 - Normalized Transient Thermal Impedance Junction to Case (25 °C) are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual pplication parameters and operating conditions

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